

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	1908	@ad<="20040415" and (257/737). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:03
L3	1269	@ad<="20040415" and (257/734). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:38
L4	471	@ad<="20040415" and (257/735). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:05
L5	1573	@ad<="20040415" and (257/777). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:05
L6	2427	@ad<="20040415" and (257/778). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:06
L7	540	@ad<="20040415" and (257/759). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:06
L9	1	"5659198".PN.	USPAT; USOCR	OR	ON	2005/11/16 14:07
L10	1	"5519936".PN.	USPAT; USOCR	OR	ON	2005/11/16 14:08
L11	1	"5359222".PN.	USPAT; USOCR	OR	ON	2005/11/16 14:09
L12	160	@ad<="20040415" and 'tab' and 'IC' and 'stiffener'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:53
L13	840	@ad<="20040415" and 'tab' and 'IC' and 'conductive' with 'trace'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:15
L14	26	@ad<="20040415" and 'tab' and 'IC' and 'stiffener' with ('dielectric' or 'photo')	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:41

L15	1584	@ad<="20040415" and (257/724). ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:38
L17	49	@ad<="20040415" and 'tab' and 'IC' same 'trace' same 'dielectric'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:16
L18	73	@ad<="20040415" and 'die' and 'TAB' and 'trace' same 'photo'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:48
L19	17	@ad<="20040415" and 'die' and 'TAB' same ('trace' or 'conductive') same 'photo'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:53
L20	666	@ad<="20040415" and 'die' and ('trace' or 'conductive' or 'conductor' or 'metal') same 'photomask'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:53
L21	35	@ad<="20040415" and 'die' and 'encapsulant' and ('trace' or 'conductive' or 'conductor' or 'metal') same 'photomask'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:23
L22	450	@ad<="20040415" and 'traces' with 'interposer'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:15
L25	6	@ad<="20040415" and 'tab' and 'IC' same 'trace' same 'dielectric' same 'mask'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:21
L26	49	@ad<="20040415" and 'tab' and 'IC' same 'trace' same 'dielectric' same 'dielectric'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:22
L27	1651	@ad<="20040415" and 'carrier substrate' and ('trace' or 'conductive' or 'conductor' or 'metal') same 'dielectric'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:40
L28	4	@ad<="20040415" and 'carrier substrate' same 'IC' same 'trace' same 'dielectric' same 'mask'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:23

L29	147	@ad<="20040415" and 'carrier substrate' same 'IC' and ('trace' or 'conductive' or 'conductor' or 'metal') same 'dielectric'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:23
L31	62	@ad<="20040415" and 'support with 'substrate' same ('trace' or 'conductive' or 'conductor' or 'metal') same 'photomask'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:41
L36	58	@ad<="20040415" and 'TAB' and 'stiffener' with 'dielectric'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:53
L37	1	"20020180040".PN.	US-PGPUB	OR	ON	2005/11/16 15:56
L38	1	"20020109226".PN.	US-PGPUB	OR	ON	2005/11/16 15:56
L39	1	"5661088".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:05
L40	1	"5579573".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:10
L41	1	"5527741".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:10
L42	1	"5378869".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:12
L43	1	"5355283".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:12
L44	1	"5527741".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:12
L45	1	"5452182".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:13
L46	1	"5661086".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:13
L47	1	"5639695".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:13
L48	1	"5450283".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:14
L49	1	"5447886".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:14
L50	1	"5390079".PN.	USPAT; USOCR	OR	ON	2005/11/16 16:14
S1	1	"20050230821"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 10:49
S2	4	'Kheng Lee Teck'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 10:46

S3	61	@ad<="20040415" and 'traces' with 'interposer' and 'dielectric' and 'IC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 15:15
S4	0	@ad<="20040415" and 'conductive traces' with 'interposer' same 'photomask'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 11:20
S5	11	@ad<="20040415" and 'conductive traces' same 'photomask' and 'IC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 11:22
S6	0	@ad<="20040415" and 'CSP' same 'photomask' and 'IC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 11:23
S7	49	@ad<="20040415" and 'CSP' same 'dielectric' and 'IC'	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/16 14:02
S8	1	"6400018".PN.	USPAT; USOCR	OR	ON	2005/11/16 11:27
S9	1	"6114187".PN.	USPAT; USOCR	OR	ON	2005/11/16 11:28
S10	1	"5973393".PN.	USPAT; USOCR	OR	ON	2005/11/16 11:28
S11	1	"5945741".PN.	USPAT; USOCR	OR	ON	2005/11/16 11:30
S12	1	"5659198".PN.	USPAT; USOCR	OR	ON	2005/11/16 11:33
S13	1	"5519936".PN.	USPAT; USOCR	OR	ON	2005/11/16 11:35
S14	1	"5359222".PN.	USPAT; USOCR	OR	ON	2005/11/16 11:35
S15	1	"5757078".PN.	USPAT; USOCR	OR	ON	2005/11/16 11:36
S16	1	"5753973".PN.	USPAT; USOCR	OR	ON	2005/11/16 11:36